Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/619,446	MALEVILLE, CHRISTOPHE	
Examiner	Art Unit	
Binh X. Tran	1765	

SEARCHED					
Class	Subclass	Date	Examiner		
438	455	9/14/2005	вт		
216	. 20	9/14/2005	вт		
			_		
		-			

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOT (INCLUDING SEARCH	ES STRATEGY	)
	DATE	EXMR
Search keywords and inventor's name using USPAT, USPG-PUB, JPO, EPO, DERWENT database	9/14/2005	ВТ